Search Notes

A	pplication/Control No.	Applicant(s)/Patent u Reexamination	nder
10	0/774,883	FUNG ET AL.	
E	xaminer	Art Unit	
P	hallaka Kik	2825	

SEARCHED					
Class	Subclass	Date	Examiner		
716	6,9,10,16, 18	2/3/2006	PK .		
716	16,18	2/7/2006	PK		
Above	updated	5/27/2006	PK		
Above	updated	8/21/2006	PK		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
716	6,9,10,16	8/21/2006	PK		
716	18	8/21/2006	PK		
	-				
USPGPUB (See attached)		8/21/2006	PK		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
BRS (EAST)USPAT, USPGPUB Class/sub searched: 716/1-18 (see attached)	2/3/2006	PK		
Above updated (see attached)	5/27/2006	РК		
Above updated (see attached)	8/21/2006	PK		
BRS (EAST)USPAT, USPGPUB Class/Sub searched: 16,18	2/7/2006	PK		
EPO, JPO, IBM TDB, Derwent (see attached)	2/3/2006	РК		
IEE/IEEE XPlore (see attached)	2/3/2006	РК		